Date Searched: 6/12/2006

Databases Searched: USPAT, USPGPUB

Plurals: ON Terms Searched:

L1 (transistor or transister) same (current near3 (source or driver))

L2 (current near3 (source or driver)) near15 (width or dimension or size)

L3 resist\$5

L4 (model\$3 or character\$8 or represent\$6) same 2

L5 2 and 3 and 4 Results: 1167 hits

L6 (716/1-18.ccls. or 703/2.ccls.) and 5

Results: 19 hits

L7 (transistor or transister) same (replac\$6 or substitut\$4 or represent\$6 or model\$3 or character\$8) same current

L8 current same (width or size or dimension)

L9 7 and 8

L10 (716/1-18.ccls. or 703/2.ccls.) and 9

Results: 305 hits

L11 current same (distribut\$4 or aggregat\$4 or combin\$7 or total) same 8

L12 10 and 11 Results: 96 hits L13 3 and 12 Results: 74 hits

L14 memory near2 array

L15 row same 14

L16 716/1-18.ccls. and 15

L17 (emf or em or migration or electro-migration or electromigration)

L18 16 and 1 Results: 10 hits

Fujine; Eiji US 6748572 B2

Sutherland; Ivan et al. US 6629301 B1

Yonezawa; Hirokazu et al. US 6219630 B1

Fujine, Eiji US 20020199160 A1

Mau, Hendrik T. et al. US 20040168136 A1

SHINOMIYA, NORIKO et al. US 20010049815 A1

Somayaji; Ananth G et al.

US 7043705 B2

Narahara; Hidetoshi et al.

US 7039572 B1

Kartschoke, Paul D. et al.

US 20050278662 A1

Heydler, Thomas et al. US 20040015787 A1 Itazu; Kazushige et al. US 6405354 B1 Young; Duane J. et al. US 6038383 A

Yonezawa, Hirokazu US 20040261044 A1

Chatterjee, Amitava et al. US 20020083399 A1 Van Heijningen; Marc et al. US 6941258 B2

Mau; Hendrik T. et al. US 6880139 B2

AKINO, T et al. JP 09102608 A

Hassibi; Arash et al. US 6954921 B2

Colleran; David M. et al. US 6909330 B2

Yamaguchi; Kenji US 6735558 B1
Demler; Michael J. US 6637018 B1

King; Ken Richard et al. US 6286127 B1

Singh, Raminderpal et al. US 20050216873 A1

Yamaguchi, Kenji US 20040098681 A1 McGaughy; Bruce W. et al. US 6928626 B1 Rahmat; Khalid et al. US 20060031795 A1

Colleran, David M. et al. US 20040230408 A1

Hassibi, Arash et al. US 20040172609 A1 Mitsuhashi; Takashi US 5404310 A Yamaguchi; Tetsuya US 6757873 B2

Pie; Charles Corey et al. US 6631506 B1 Chatterjee; Amitava et al. US 6598214 B2

Chandra; Rajit et al. US 6591402 B1
Misheloff; Michael N. et al. US 5461579 A
Sugasawara; Emery O. et al. US 6102962 A

Tamaki; Yoichi et al. US 6662344 B2 Yasuda; Takeshi US 6330526 B1 Jung, Chul M. US 20050081172 A1

Bhamidipaty: Achyutram US 6874132 B1

Djaja; Gregory et al. US 6405160 B1

Databases Searched: EPO, JPO, IBM TDB, Derwent

Plurals: ON Terms Searched:

L1 (transistor or transister) same (current near3 (source or driver))

L2 (current near3 (source or driver)) near15 (width or dimension or size)

L3 resist\$5

L4 (model\$3 or character\$8 or represent\$6) same 1

L5 2 and 3 and 4

Results: 22 hits

L6 (transistor or transister) same (replac\$6 or substitut\$4 or represent\$6 or model\$3 or character\$8) same current

L7 current same (width or size or dimension)

L8 current same (distribut\$4 or aggregat\$4 or combin\$7 or total) same 7

L9 3 and 6 and 8

Results: 62 hits

JP 09102608 A DERWENT AKINO, T et al.

Databases Searched: IEE/IEEE Xplore

Terms Searched: (transistor or transister) and (current <near/3> (source or driver)) and

(width or dimension or size) and resist* and

(model* or character* or represent*)

Results: Your search matched 2 of 1356463 documents

Terms Searched: (transistor or transister) and (replac* or substitut* or represent* or model* or character*) and current and (width or size or dimension) and (distribut* or aggregat* or

combin* or total) and resist*

Results: Your search matched 32 of 1356463 documents